

Application/Control N	Applicant(s)/Patent under Reexamination	
10/721,333	GALAND ET AL.	
Examiner	Art Unit	
Suk Jin Kang	2619	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>		1		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	7/26/2007	sjk		
Inventor name and Assignee search in PALM ExPO and EAST	7/26/2007	SJK		
Consulted with Chau Nguyen (SPE)	7/26/2007	SJK		
(709/228, 227.ccls)	7/26/2007	SJK		
Consulted with Chau Nguyen (SPE)	1/14/2008	SJK		
370/230,230.1,232,235,236,395.21, 252 and 709/227,228 (text search only - see search history printout)	1/17/2008	SJK		
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